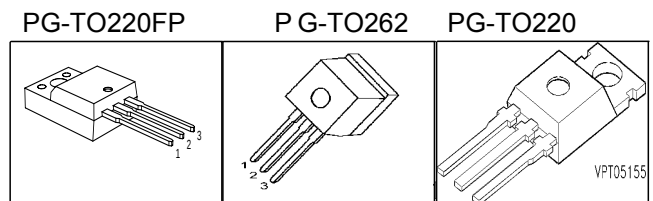


## Cool MOS™ Power Transistor

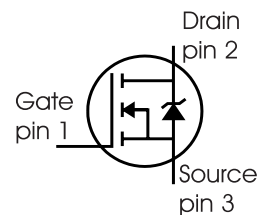
### Feature

- New revolutionary high voltage technology
- Worldwide best  $R_{DS(on)}$  in TO 220
- Ultra low gate charge
- Periodic avalanche rated
- Extreme  $dv/dt$  rated
- Ultra low effective capacitances
- Improved transconductance
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC<sup>0)</sup> for target applications

|                     |      |          |
|---------------------|------|----------|
| $V_{DS} @ T_{jmax}$ | 560  | V        |
| $R_{DS(on)}$        | 0.19 | $\Omega$ |
| $I_D$               | 21   | A        |



| Type       | Package    | Ordering Code | Marking |
|------------|------------|---------------|---------|
| SPP21N50C3 | PG-TO220   | Q67040-S4565  | 21N50C3 |
| SPI21N50C3 | PG-TO262   | Q67040-S4564  | 21N50C3 |
| SPA21N50C3 | PG-TO220FP | SP000216364   | 21N50C3 |



### Maximum Ratings

| Parameter                                                                                                           | Symbol             | Value      |                                        | Unit             |
|---------------------------------------------------------------------------------------------------------------------|--------------------|------------|----------------------------------------|------------------|
|                                                                                                                     |                    | SPP_I      | SPA                                    |                  |
| Continuous drain current<br>$T_C = 25^\circ\text{C}$<br>$T_C = 100^\circ\text{C}$                                   | $I_D$              | 21<br>13.1 | 21 <sup>1)</sup><br>13.1 <sup>1)</sup> | A                |
| Pulsed drain current, $t_p$ limited by $T_{jmax}$                                                                   | $I_D \text{ puls}$ | 63         | 63                                     | A                |
| Avalanche energy, single pulse<br>$I_D=10\text{A}$ , $V_{DD}=50\text{V}$                                            | $E_{AS}$           | 690        | 690                                    | mJ               |
| Avalanche energy, repetitive $t_{AR}$ limited by $T_{jmax}$ <sup>2)</sup><br>$I_D=21\text{A}$ , $V_{DD}=50\text{V}$ | $E_{AR}$           | 1          | 1                                      |                  |
| Avalanche current, repetitive $t_{AR}$ limited by $T_{jmax}$                                                        | $I_{AR}$           | 21         | 21                                     | A                |
| Gate source voltage                                                                                                 | $V_{GS}$           | $\pm 20$   | $\pm 20$                               | V                |
| Gate source voltage AC ( $f > 1\text{Hz}$ )                                                                         | $V_{GS}$           | $\pm 30$   | $\pm 30$                               |                  |
| Power dissipation, $T_C = 25^\circ\text{C}$                                                                         | $P_{tot}$          | 208        | 34.5                                   | W                |
| Operating and storage temperature                                                                                   | $T_j, T_{stg}$     | -55...+150 |                                        | $^\circ\text{C}$ |
| Reverse diode $dv/dt$ <sup>7)</sup>                                                                                 | $dv/dt$            | 15         |                                        | V/ns             |

**Maximum Ratings**

| Parameter                                                                                                 | Symbol  | Value | Unit |
|-----------------------------------------------------------------------------------------------------------|---------|-------|------|
| Drain Source voltage slope<br>$V_{DS} = 400 \text{ V}$ , $I_D = 21 \text{ A}$ , $T_j = 125^\circ\text{C}$ | $dv/dt$ | 50    | V/ns |

**Thermal Characteristics**

| Parameter                                                                                         | Symbol                | Values |         |         | Unit |
|---------------------------------------------------------------------------------------------------|-----------------------|--------|---------|---------|------|
|                                                                                                   |                       | min.   | typ.    | max.    |      |
| Thermal resistance, junction - case                                                               | $R_{thJC}$            | -      | -       | 0.6     | K/W  |
| Thermal resistance, junction - case, FullPAK                                                      | $R_{thJC \text{ FP}}$ | -      | -       | 3.6     |      |
| Thermal resistance, junction - ambient, leaded                                                    | $R_{thJA}$            | -      | -       | 62      |      |
| Thermal resistance, junction - ambient, FullPAK                                                   | $R_{thJA \text{ FP}}$ | -      | -       | 80      |      |
| SMD version, device on PCB:<br>@ min. footprint<br>@ 6 cm <sup>2</sup> cooling area <sup>3)</sup> | $R_{thJA}$            | -<br>- | -<br>35 | 62<br>- |      |
| Soldering temperature, wavesoldering<br>1.6 mm (0.063 in.) from case for 10s <sup>4)</sup>        | $T_{sold}$            | -      | -       | 260     | °C   |

**Electrical Characteristics, at  $T_j=25^\circ\text{C}$  unless otherwise specified**

| Parameter                                   | Symbol        | Conditions                                                                                       | Values |              |           | Unit          |
|---------------------------------------------|---------------|--------------------------------------------------------------------------------------------------|--------|--------------|-----------|---------------|
|                                             |               |                                                                                                  | min.   | typ.         | max.      |               |
| Drain-source breakdown voltage              | $V_{(BR)DSS}$ | $V_{GS}=0\text{V}$ , $I_D=0.25\text{mA}$                                                         | 500    | -            | -         | V             |
| Drain-Source avalanche<br>breakdown voltage | $V_{(BR)DS}$  | $V_{GS}=0\text{V}$ , $I_D=21\text{A}$                                                            | -      | 600          | -         |               |
| Gate threshold voltage                      | $V_{GS(th)}$  | $I_D=1000\mu\text{A}$ , $V_{GS}=V_{DS}$                                                          | 2.1    | 3            | 3.9       |               |
| Zero gate voltage drain current             | $I_{DSS}$     | $V_{DS}=500\text{V}$ , $V_{GS}=0\text{V}$ ,<br>$T_j=25^\circ\text{C}$<br>$T_j=150^\circ\text{C}$ | -<br>- | 0.1<br>-     | 1<br>100  | $\mu\text{A}$ |
| Gate-source leakage current                 | $I_{GSS}$     | $V_{GS}=20\text{V}$ , $V_{DS}=0\text{V}$                                                         | -      | -            | 100       |               |
| Drain-source on-state resistance            | $R_{DS(on)}$  | $V_{GS}=10\text{V}$ , $I_D=13.1\text{A}$ ,<br>$T_j=25^\circ\text{C}$<br>$T_j=150^\circ\text{C}$  | -<br>- | 0.16<br>0.54 | 0.19<br>- | $\Omega$      |
| Gate input resistance                       | $R_G$         | $f=1\text{MHz}$ , open drain                                                                     | -      | 0.53         | -         |               |

## Electrical Characteristics

| Parameter                                                     | Symbol       | Conditions                                                                 | Values |      |      | Unit |
|---------------------------------------------------------------|--------------|----------------------------------------------------------------------------|--------|------|------|------|
|                                                               |              |                                                                            | min.   | typ. | max. |      |
| Transconductance                                              | $g_{fs}$     | $V_{DS} \geq 2 \cdot I_D \cdot R_{DS(on)max}$ ,<br>$I_D = 13.1A$           | -      | 18   | -    | S    |
| Input capacitance                                             | $C_{iss}$    | $V_{GS} = 0V$ , $V_{DS} = 25V$ ,<br>$f = 1MHz$                             | -      | 2400 | -    | pF   |
| Output capacitance                                            | $C_{oss}$    |                                                                            | -      | 1200 | -    |      |
| Reverse transfer capacitance                                  | $C_{rss}$    |                                                                            | -      | 30   | -    |      |
| Effective output capacitance, <sup>5)</sup><br>energy related | $C_{o(er)}$  | $V_{GS} = 0V$ , $V_{DS} = 400V$                                            | -      | 87   | -    |      |
| Effective output capacitance, <sup>6)</sup><br>time related   | $C_{o(tr)}$  |                                                                            | -      | 181  | -    |      |
| Turn-on delay time                                            | $t_{d(on)}$  | $V_{DD} = 380V$ , $V_{GS} = 0/10V$ ,<br>$I_D = 21A$ ,<br>$R_G = 3.6\Omega$ | -      | 10   | -    | ns   |
| Rise time                                                     | $t_r$        |                                                                            | -      | 5    | -    |      |
| Turn-off delay time                                           | $t_{d(off)}$ |                                                                            | -      | 67   | -    |      |
| Fall time                                                     | $t_f$        |                                                                            | -      | 4.5  | -    |      |

## Gate Charge Characteristics

|                       |                 |                                                          |   |    |   |    |
|-----------------------|-----------------|----------------------------------------------------------|---|----|---|----|
| Gate to source charge | $Q_{gs}$        | $V_{DD} = 380V$ , $I_D = 21A$                            | - | 10 | - | nC |
| Gate to drain charge  | $Q_{gd}$        |                                                          | - | 50 | - |    |
| Gate charge total     | $Q_g$           | $V_{DD} = 380V$ , $I_D = 21A$ ,<br>$V_{GS} = 0$ to $10V$ | - | 95 | - |    |
| Gate plateau voltage  | $V_{(plateau)}$ | $V_{DD} = 380V$ , $I_D = 21A$                            | - | 5  | - | V  |

<sup>0</sup>J-STD20 and JESD22

<sup>1</sup>Limited only by maximum temperature

<sup>2</sup>Repetitive avalanche causes additional power losses that can be calculated as  $P_{AV} = E_{AR} \cdot f$ .

<sup>3</sup>Device on 40mm\*40mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical without blown air.

<sup>4</sup>Soldering temperature for TO-263: 220°C, reflow

<sup>5</sup> $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

<sup>6</sup> $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

<sup>7</sup> $I_{SD} \leq I_D$ ,  $di/dt \leq 200A/\mu s$ ,  $V_{DClamp} = 400V$ ,  $V_{peak} < V_{BR, DSS}$ ,  $T_j < T_{j,max}$ .

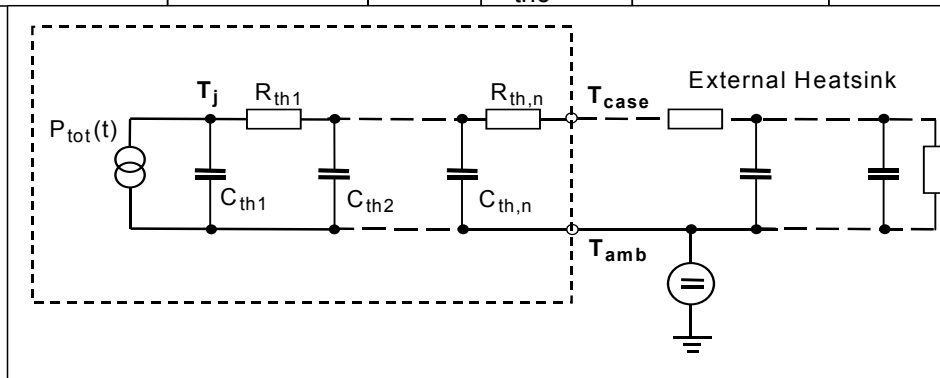
Identical low-side and high-side switch.

### Electrical Characteristics

| Parameter                                     | Symbol       | Conditions                                                  | Values |      |      | Unit                   |
|-----------------------------------------------|--------------|-------------------------------------------------------------|--------|------|------|------------------------|
|                                               |              |                                                             | min.   | typ. | max. |                        |
| Inverse diode continuous forward current      | $I_S$        | $T_C=25^{\circ}\text{C}$                                    | -      | -    | 21   | A                      |
| Inverse diode direct current, pulsed          | $I_{SM}$     |                                                             | -      | -    | 63   |                        |
| Inverse diode forward voltage                 | $V_{SD}$     | $V_{GS}=0\text{V}, I_F=I_S$                                 | -      | 1    | 1.2  | V                      |
| Reverse recovery time                         | $t_{rr}$     | $V_R=380\text{V}, I_F=I_S, di_F/dt=100\text{A}/\mu\text{s}$ | -      | 450  | 720  | ns                     |
| Reverse recovery charge                       | $Q_{rr}$     |                                                             | -      | 9    | -    | $\mu\text{C}$          |
| Peak reverse recovery current                 | $I_{rrm}$    |                                                             | -      | 60   | -    | A                      |
| Peak rate of fall of reverse recovery current | $di_{rr}/dt$ | $T_j=25^{\circ}\text{C}$                                    | -      | 1200 | -    | $\text{A}/\mu\text{s}$ |

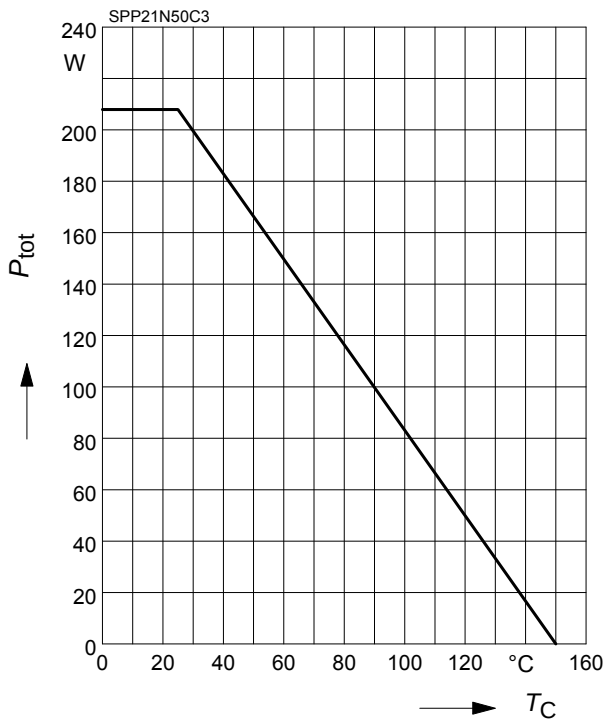
### Typical Transient Thermal Characteristics

| Symbol    | Value   |         | Unit | Symbol    | Value     |           | Unit |
|-----------|---------|---------|------|-----------|-----------|-----------|------|
|           | SPP_I   | SPA     |      |           | SPP_I     | SPA       |      |
| $R_{th1}$ | 0.00769 | 0.00769 | K/W  | $C_{th1}$ | 0.0003763 | 0.0003763 | Ws/K |
| $R_{th2}$ | 0.015   | 0.015   |      | $C_{th2}$ | 0.001411  | 0.001411  |      |
| $R_{th3}$ | 0.029   | 0.029   |      | $C_{th3}$ | 0.001931  | 0.001931  |      |
| $R_{th4}$ | 0.114   | 0.16    |      | $C_{th4}$ | 0.005297  | 0.005297  |      |
| $R_{th5}$ | 0.136   | 0.319   |      | $C_{th5}$ | 0.012     | 0.008659  |      |
| $R_{th6}$ | 0.059   | 2.523   |      | $C_{th6}$ | 0.091     | 0.412     |      |



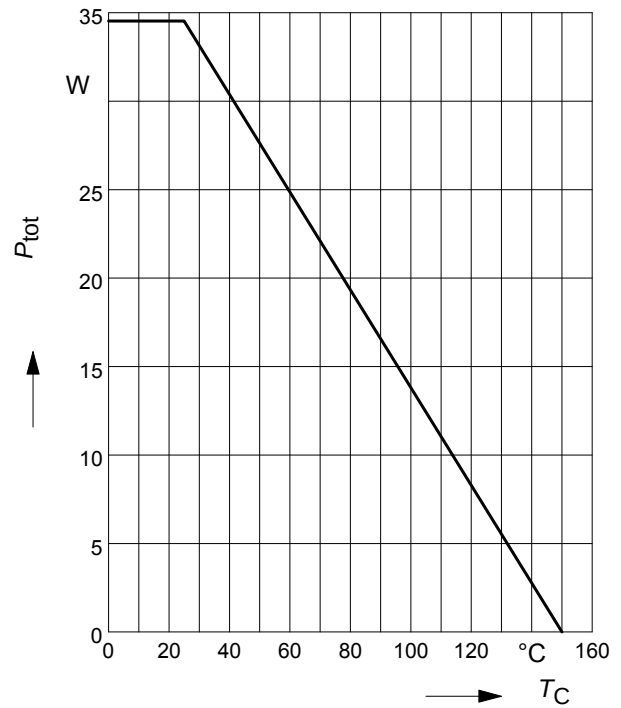
### 1 Power dissipation

$$P_{\text{tot}} = f(T_C)$$



### 2 Power dissipation FullPAK

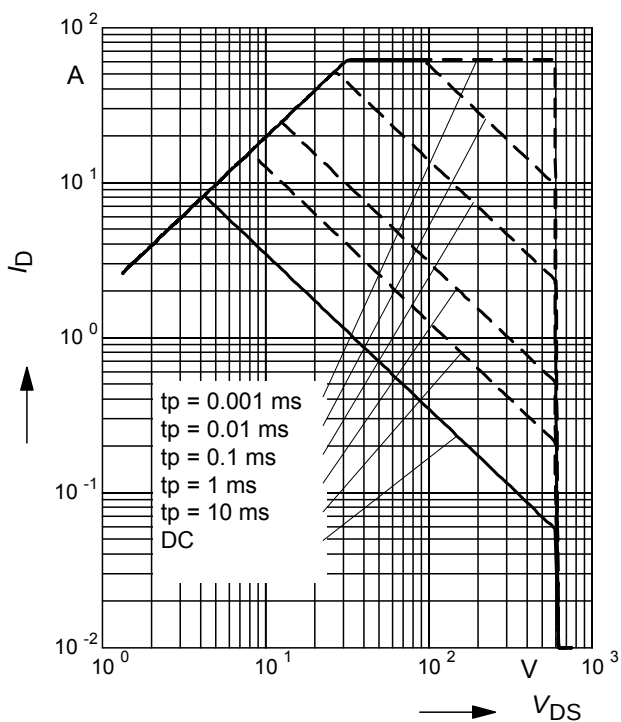
$$P_{\text{tot}} = f(T_C)$$



### 3 Safe operating area

$$I_D = f(V_{DS})$$

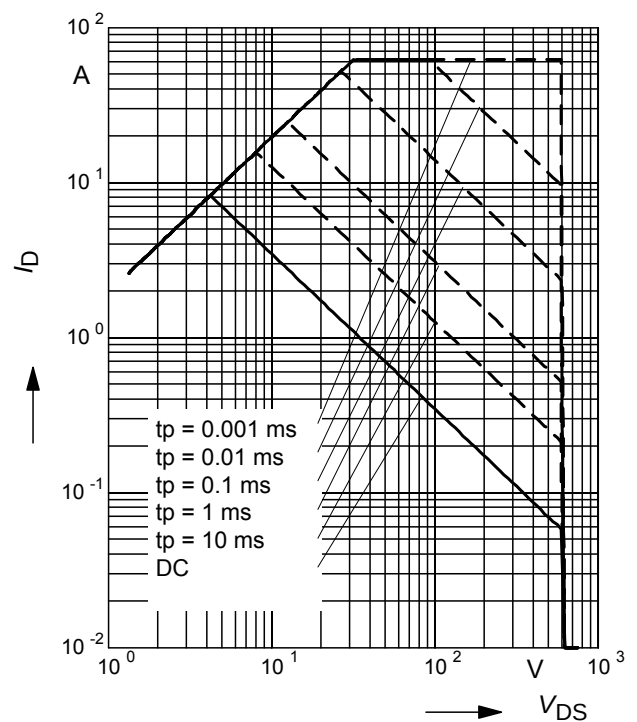
parameter :  $D = 0$  ,  $T_C = 25^\circ\text{C}$



### 4 Safe operating area FullPAK

$$I_D = f(V_{DS})$$

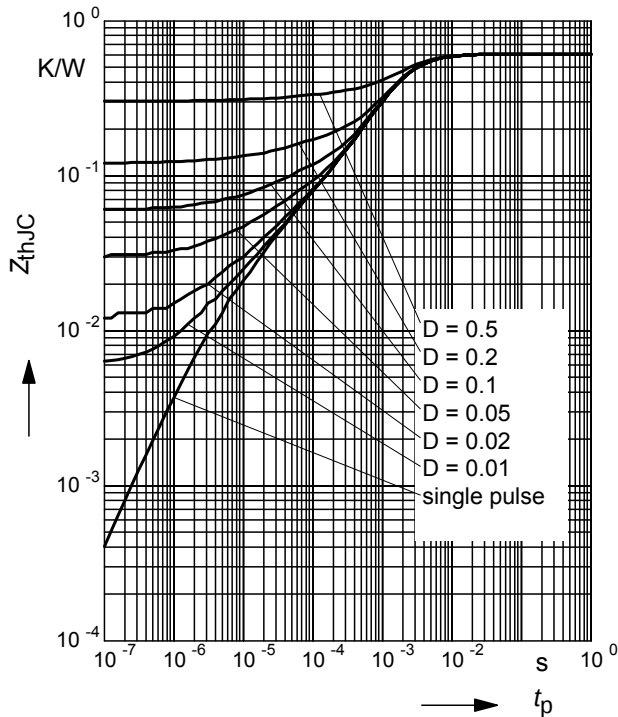
parameter:  $D = 0$  ,  $T_C = 25^\circ\text{C}$



### 5 Transient thermal impedance

$$Z_{thJC} = f(t_p)$$

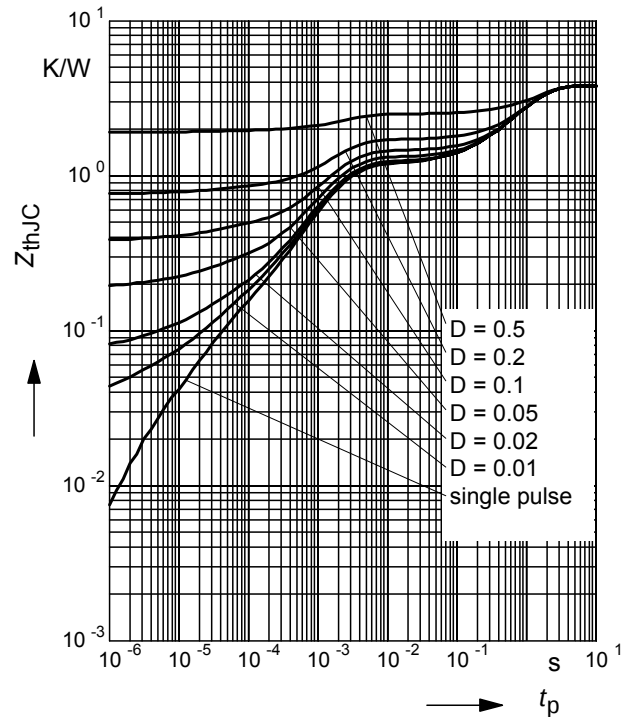
parameter:  $D = t_p/T$



### 6 Transient thermal impedance FullPAK

$$Z_{thJC} = f(t_p)$$

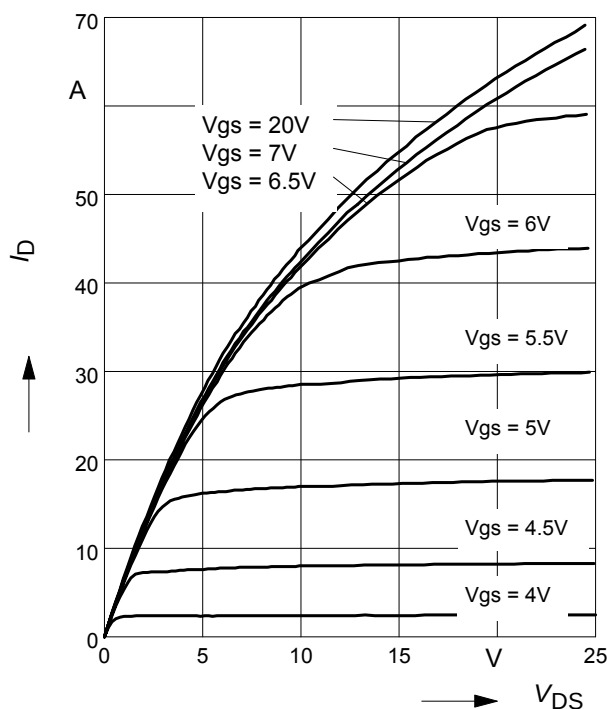
parameter:  $D = t_p/t$



### 7 Typ. output characteristic

$$I_D = f(V_{DS}); T_j = 25^\circ\text{C}$$

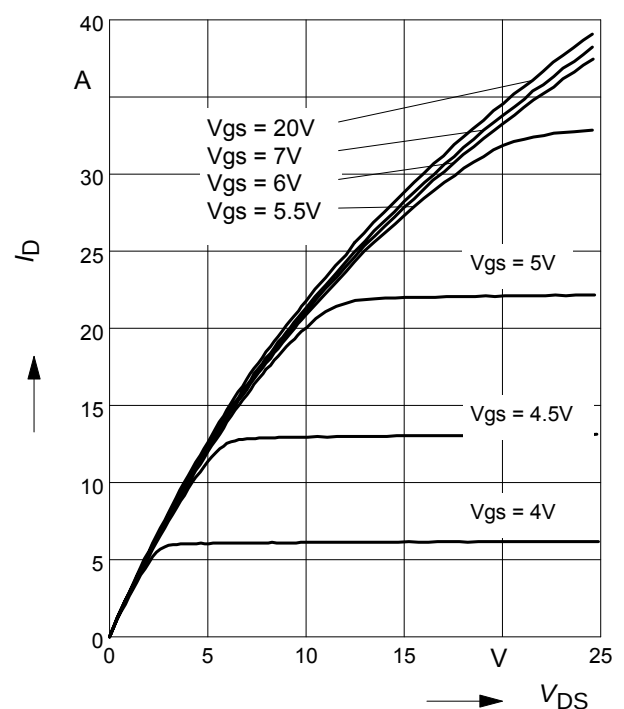
parameter:  $t_p = 10 \mu\text{s}, V_{GS}$



### 8 Typ. output characteristic

$$I_D = f(V_{DS}); T_j = 150^\circ\text{C}$$

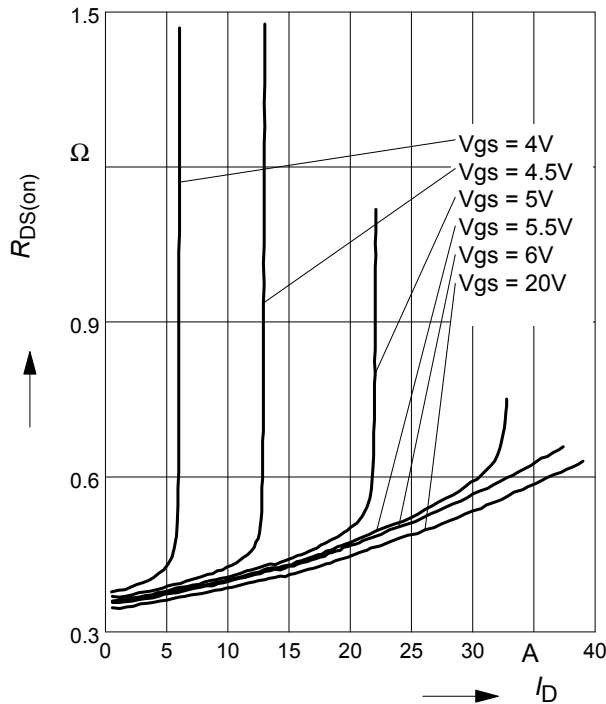
parameter:  $t_p = 10 \mu\text{s}, V_{GS}$



### 9 Typ. drain-source on resistance

$$R_{DS(on)} = f(I_D)$$

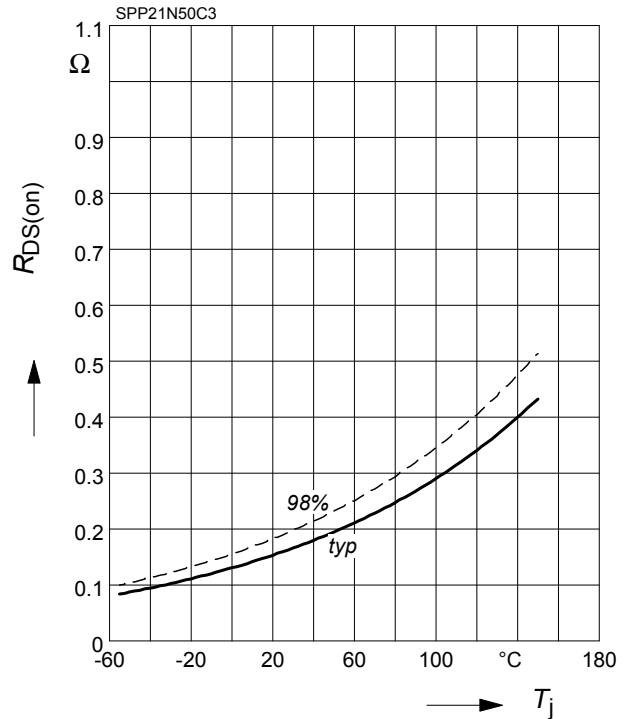
parameter:  $T_j = 150^\circ\text{C}$ ,  $V_{GS}$



### 10 Drain-source on-state resistance

$$R_{DS(on)} = f(T_j)$$

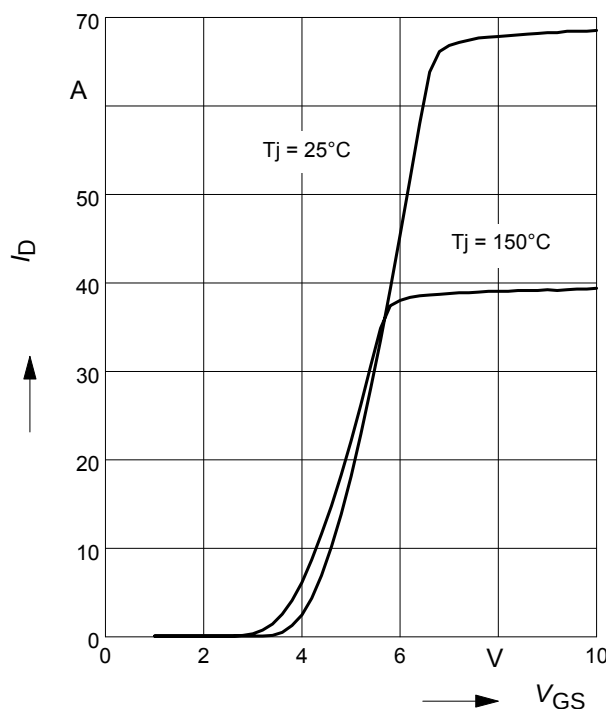
parameter:  $I_D = 13.1\text{ A}$ ,  $V_{GS} = 10\text{ V}$



### 11 Typ. transfer characteristics

$$I_D = f(V_{GS}); V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$$

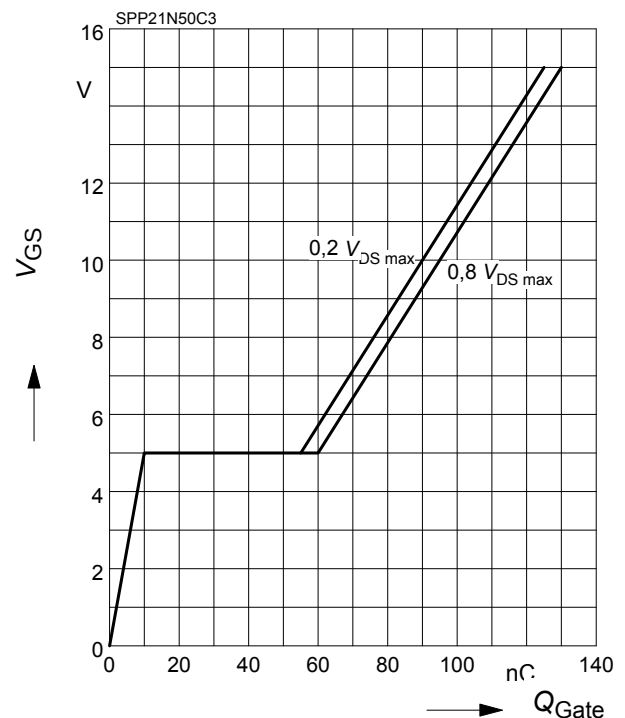
parameter:  $t_p = 10\text{ }\mu\text{s}$



### 12 Typ. gate charge

$$V_{GS} = f(Q_{Gate})$$

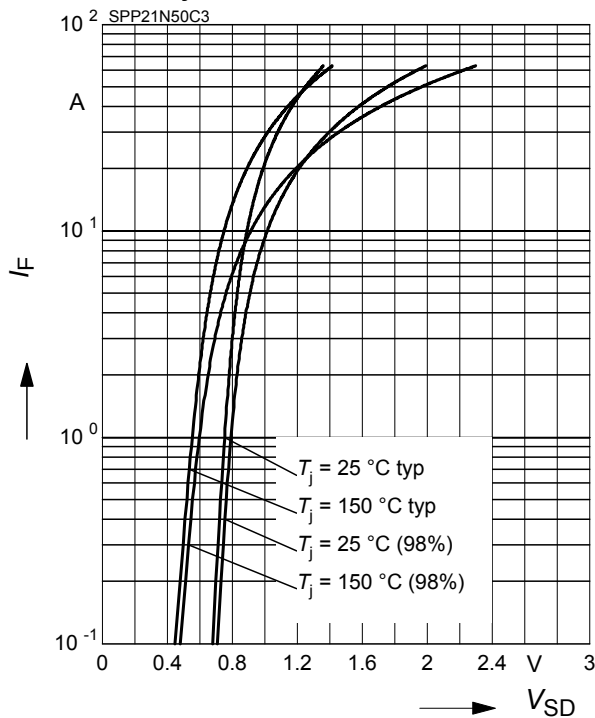
parameter:  $I_D = 21\text{ A}$  pulsed



### 13 Forward characteristics of body diode

$$I_F = f(V_{SD})$$

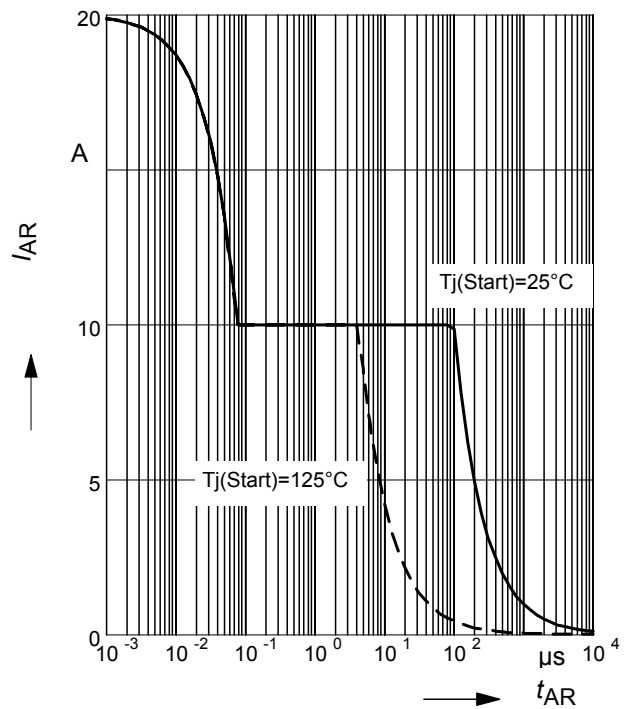
parameter:  $T_j$ ,  $t_p = 10 \mu s$



### 14 Avalanche SOA

$$I_{AR} = f(t_{AR})$$

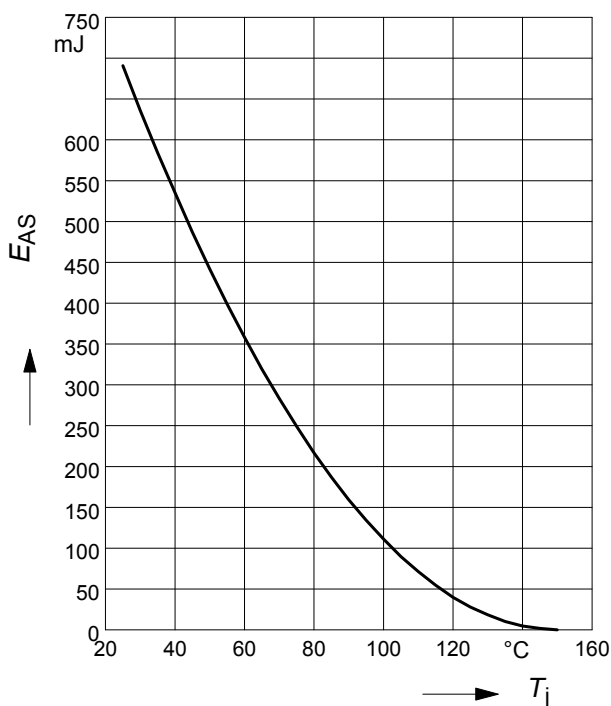
par.:  $T_j \leq 150 \text{ °C}$



### 15 Avalanche energy

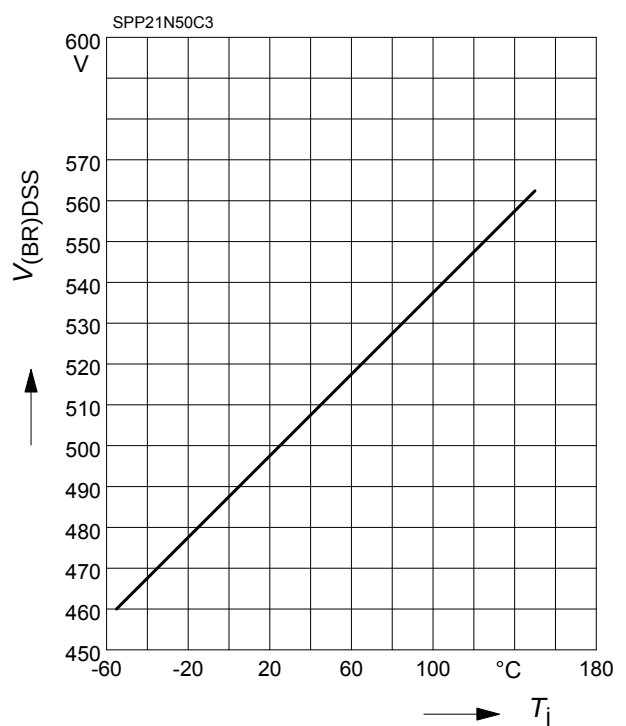
$$E_{AS} = f(T_j)$$

par.:  $I_D = 10 \text{ A}$ ,  $V_{DD} = 50 \text{ V}$



### 16 Drain-source breakdown voltage

$$V_{(BR)DSS} = f(T_j)$$

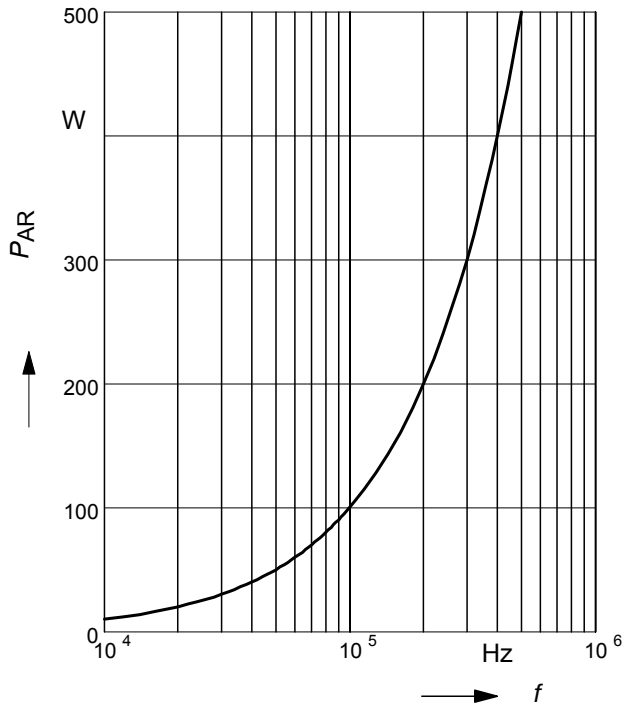




### 17 Avalanche power losses

$$P_{AR} = f(f)$$

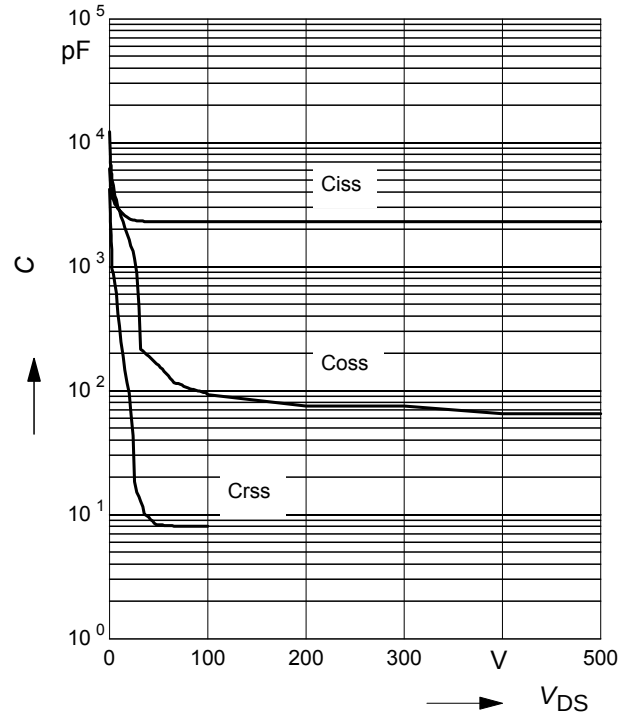
parameter:  $E_{AR}=1\text{mJ}$



### 18 Typ. capacitances

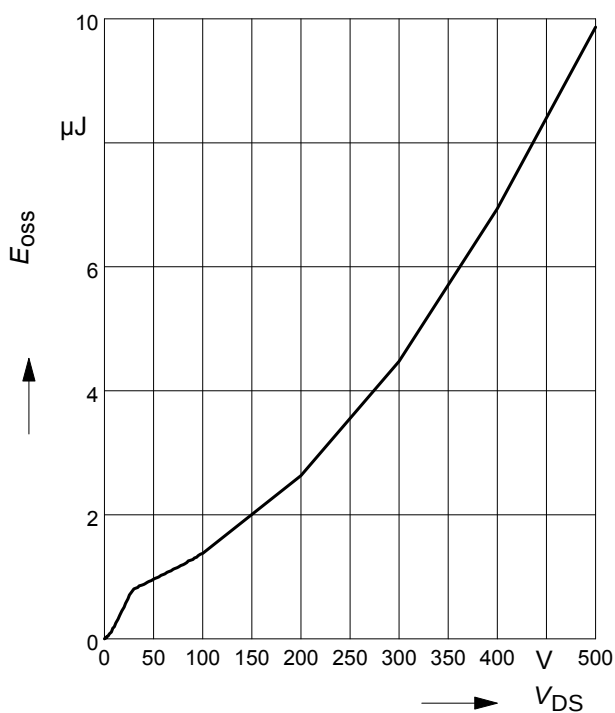
$$C = f(V_{DS})$$

parameter:  $V_{GS}=0\text{V}$ ,  $f=1\text{ MHz}$

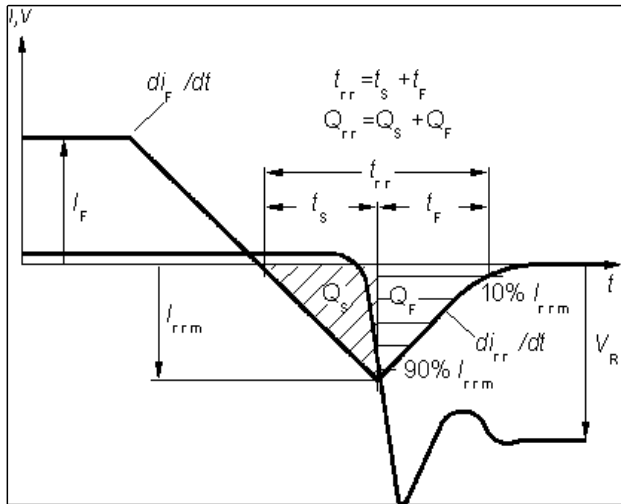


### 19 Typ. $C_{OSS}$ stored energy

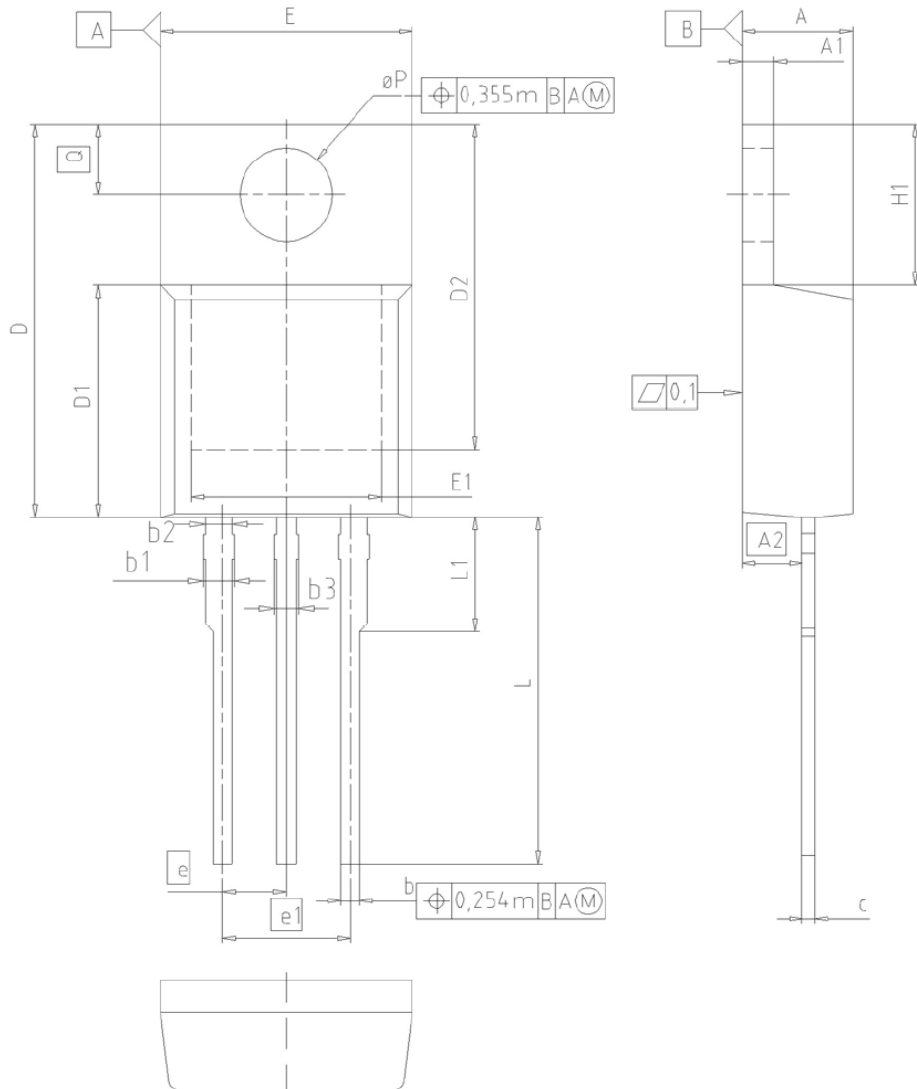
$$E_{oss}=f(V_{DS})$$



## Definition of diodes switching characteristics



PG-TO220-3-1, PG-TO220-3-21



| DIM       | MILLIMETERS |       | INCHES |       |
|-----------|-------------|-------|--------|-------|
|           | MIN         | MAX   | MIN    | MAX   |
| <b>A</b>  | 4.30        | 4.57  | 0.169  | 0.180 |
| <b>A1</b> | 1.17        | 1.40  | 0.046  | 0.055 |
| <b>A2</b> | 2.15        | 2.72  | 0.085  | 0.107 |
| <b>b</b>  | 0.65        | 0.86  | 0.026  | 0.034 |
| <b>b1</b> | 0.95        | 1.40  | 0.037  | 0.055 |
| <b>b2</b> | 0.95        | 1.15  | 0.037  | 0.045 |
| <b>b3</b> | 0.65        | 1.15  | 0.026  | 0.045 |
| <b>c</b>  | 0.33        | 0.60  | 0.013  | 0.024 |
| <b>D</b>  | 14.81       | 15.95 | 0.583  | 0.628 |
| <b>D1</b> | 8.51        | 9.45  | 0.335  | 0.372 |
| <b>D2</b> | 12.19       | 13.10 | 0.480  | 0.516 |
| <b>E</b>  | 9.70        | 10.36 | 0.382  | 0.408 |
| <b>E1</b> | 6.50        | 8.60  | 0.256  | 0.339 |
| <b>e</b>  | 2.54        |       | 0.100  |       |
| <b>e1</b> | 5.08        |       | 0.200  |       |
| <b>N</b>  | 3           |       | 3      |       |
| <b>H1</b> | 5.90        | 6.90  | 0.232  | 0.272 |
| <b>L</b>  | 13.00       | 14.00 | 0.512  | 0.551 |
| <b>L1</b> | -           | 4.80  | -      | 0.189 |
| <b>øP</b> | 3.60        | 3.89  | 0.142  | 0.153 |
| <b>Q</b>  | 2.60        | 3.00  | 0.102  | 0.118 |

**DOCUMENT NO.**  
Z8B00003318

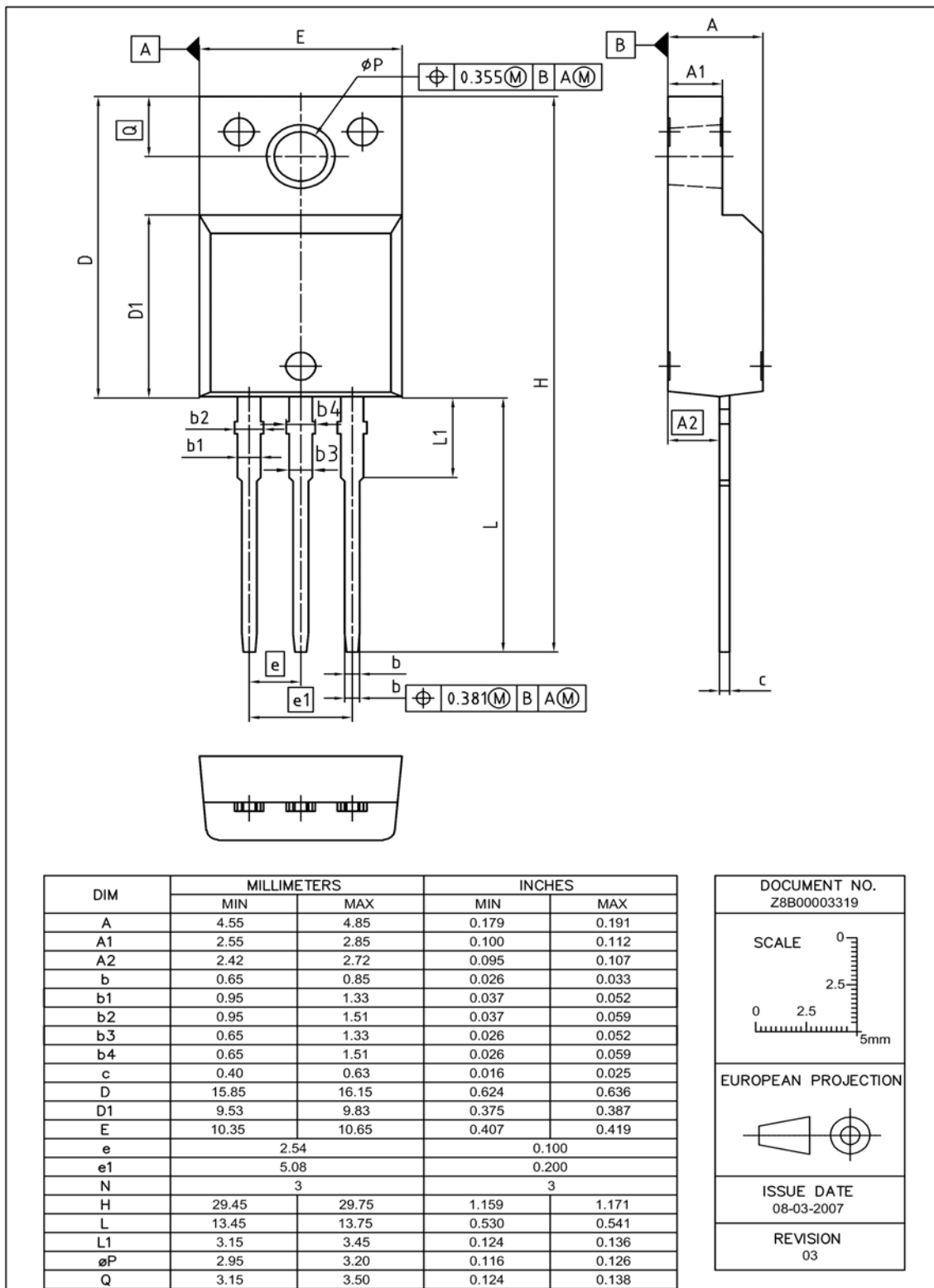
**SCALE**  
0 2.5 5mm

**EUROPEAN PROJECTION**

**ISSUE DATE**  
23-08-2007

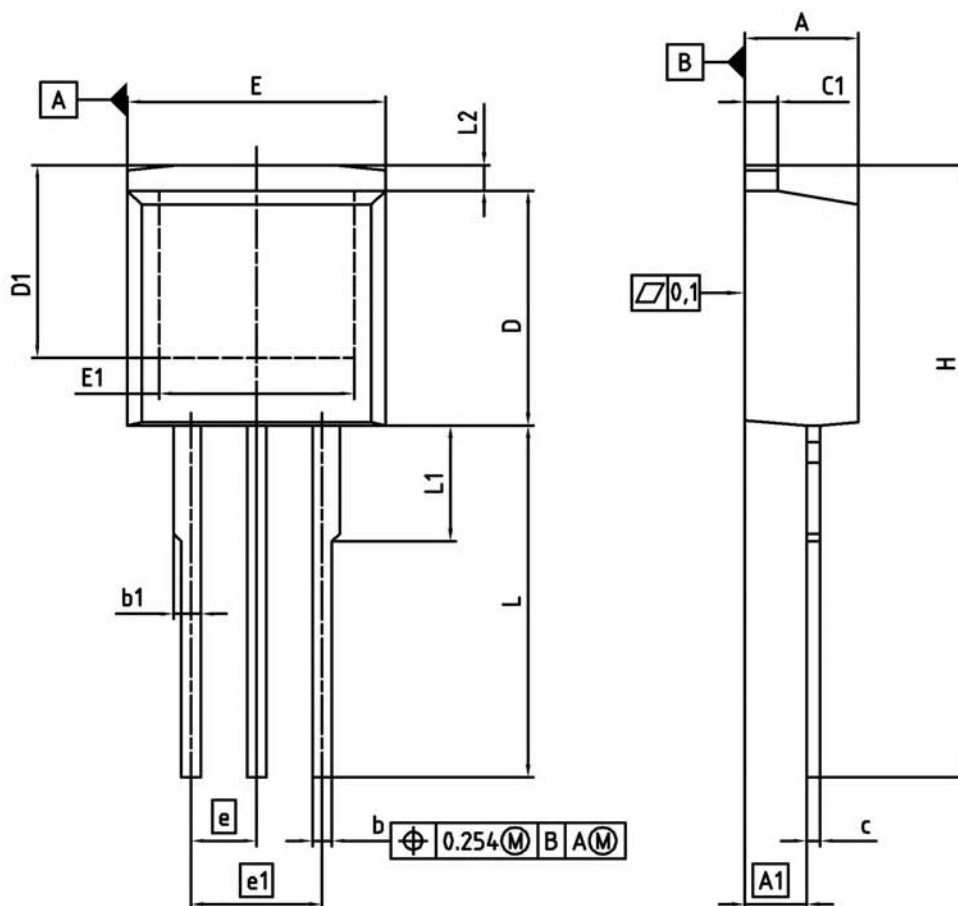
**REVISION**  
05

PG-TO220-3 (Fully isolated)

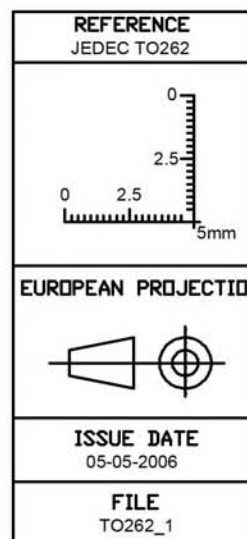


Dimensions in mm/ inches

PG-TO262-3-1, PG-TO262-3-21 (I<sup>2</sup>-PAK)



| DIM | MILLIMETERS |        | INCHES |       |
|-----|-------------|--------|--------|-------|
|     | MIN         | MAX    | MIN    | MAX   |
| A   | 4.300       | 4.572  | 0.169  | 0.180 |
| A1  | 2.150       | 2.718  | 0.085  | 0.107 |
| b   | 0.650       | 0.864  | 0.026  | 0.034 |
| b1  | 0.635       | 1.400  | 0.025  | 0.055 |
| c   | 0.330       | 0.600  | 0.013  | 0.024 |
| c1  | 1.170       | 1.400  | 0.046  | 0.055 |
| D   | 8.509       | 9.450  | 0.335  | 0.372 |
| D1  | 6.900       | -      | 0.272  | -     |
| E   | 9.700       | 10.363 | 0.382  | 0.408 |
| E1  | 6.500       | 8.600  | 0.256  | 0.339 |
| e   | 2.540       |        | 0.100  |       |
| e1  | 5.080       |        | 0.200  |       |
| N   | 3           |        | 3      |       |
| L   | 13.000      | 14.000 | 0.512  | 0.551 |
| L1  | -           | 4.800  | -      | 0.189 |
| L2  | -           | 1.727  | -      | 0.068 |



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